Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/749,489	JWA, SEUNG HEE	
Examiner	Art Unit	•
Lee Calvin	2818 2006	3/10020

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	301-315	1/31/2005	CL
438	257-267	#	#
#	593, 594	#	#
Updated	Search	6/8/2005	CL
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438	260	6/9/2005	CL
257	314	#	#

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